



# Precision, Micropower LDO Voltage References in TSOT-23

Preliminary Technical Data **ADR121/ADR125/ADR127**

## FEATURES

### Initial Accuracy:

A-Grade:  $\pm 0.24\%$

B-Grade:  $\pm 0.12\%$

### Max. Tempco.

A-Grade: 25ppm/°C

B-Grade: 9ppm/°C

Low Dropout: 300mV

High Output Current: +5mA/-2mA

Low Operating Current: 85µA

Input Range: 2.7V to 18V

Temperature Range: -40°C to +125°C

Tiny TSOT-23-6 Package

## APPLICATIONS

Battery-Powered Instrumentation

Portable Medical Equipment

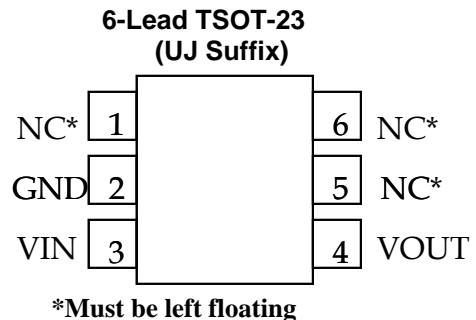
Data Acquisition Systems

Automotive

## GENERAL DESCRIPTION

The ADR12x is a family of micropower high precision, series mode bandgap reference with sink and source capability. It features high accuracy, and low-power consumption in a tiny package. The ADR12x design includes a patented temperature drift curvature correction techniques minimizes the non-linearities in the output voltage vs. temperature characteristics.

## PIN CONFIGURATION



The ADR12x is a low-dropout voltage reference, requiring only 300mV above the nominal output voltage on the input to provide a stable output voltage. This low dropout performance coupled with the low 85uA operating current makes the ADR12x ideal for battery-powered applications.

Available in industrial temperature range of -40°C to +125°C, the ADR12x is housed in the tiny TSOT-23-6 package.

## ORDERING GUIDE

Model	Vout	Initial Accuracy	Max. Tempco	Package
ADR127AUJZ	1.25V	+3mV	25ppm/°C	TSOT-23-6 (lead-free)
ADR127BUJZ	1.25V	+1.5mV	9ppm/°C	TSOT-23-6 (lead-free)
ADR121AUJZ	2.5V	+6mV	25ppm/°C	TSOT-23-6 (lead-free)
ADR121BUJZ	2.5V	+3mV	9ppm/°C	TSOT-23-6 (lead-free)
ADR125AUJZ	5.0V	+12mV	25ppm/°C	TSOT-23-6 (lead-free)
ADR125BUJZ	5.0V	+6mV	9ppm/°C	TSOT-23-6 (lead-free)

REV. PrA

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# Preliminary Technical Data

# ADR121/ADR125/ADR127

ADR127 ELECTRICAL CHARACTERISTICS (@  $T_A = 25^\circ\text{C}$ , 2.7V to 18V, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITION	Min	Typ	Max	UNITS
Output Voltage	$V_O$	@ $25^\circ\text{C}$	1.2485	1.25	1.2515	V
B-Grade						
A-Grade			1.2470	1.25	1.2530	V
Initial Accuracy Error	$V_{OERR}$	@ $25^\circ\text{C}$	-0.12		+0.12	%
B-Grade						
A-Grade			-0.24		+0.24	%
Temperature Coefficient	$TCV_O$	$-40^\circ\text{C} < T_A < +125^\circ\text{C}$		3	9	ppm/ $^\circ\text{C}$
B-Grade						
A-Grade				15	25	ppm/ $^\circ\text{C}$
Load Regulation		$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ ; $V_{IN} = 3.0\text{V}$ $0\text{mA} < I_{OUT} < 5\text{mA}$			0.5	mV/mA
		$40^\circ\text{C} < T_A < +125^\circ\text{C}$ ; $V_{IN} = 3.0\text{V}$ $-2\text{mA} < I_{OUT} < 0\text{mA}$			0.5	mV/mA
Line Regulation		2.7V to 18V $I_{OUT} = 0\text{mA}$			90	ppm/V
Ripple Rejection	$\frac{\Delta V_{OUT}}{\Delta V_{IN}}$	f= 60Hz		60		dB
Quiescent Current	$I_Q$	$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ , No Load $V_{IN} = 18\text{V}$ $V_{IN} = 2.7\text{V}$		95	125	$\mu\text{A}$
Short Circuit Current to Ground		$V_{IN} = 5.0\text{V}$		25		mA
Noise Voltage		@ $25^\circ\text{C}$ 0.1Hz to 10Hz		10		$\mu\text{V}_{p-p}$
Turn-on Settling Time		To 0.1%, $C_L = 0.2 \mu\text{F}$		200		$\mu\text{s}$
Long-Term Stability		1,000 Hours @ $25^\circ\text{C}$		TBD		ppm/1000 hrs.
Output Voltage Hysteresis				TBD		ppm

# Preliminary Technical Data

# ADR121/ADR125/ADR127

ADR121 ELECTRICAL CHARACTERISTICS (@  $T_A = 25^\circ\text{C}$ ,  $V_{IN} = 2.8\text{V}$  to  $18\text{V}$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITION	Min	Typ	Max	UNITS
Output Voltage	$V_O$	@ $25^\circ\text{C}$				
B-Grade			2.497	2.5	2.503	V
A-Grade			2.494	2.5	2.506	V
Initial Accuracy Error	$V_{OERR}$	@ $25^\circ\text{C}$				
B-Grade			-0.12		+0.12	%
A-Grade			-0.24		+0.24	%
Temperature Coefficient	$TCV_O$	$-40^\circ\text{C} < T_A < +125^\circ\text{C}$				
B-Grade				3	9	ppm/ $^\circ\text{C}$
A-Grade				15	25	ppm/ $^\circ\text{C}$
Dropout ( $V_{IN} - V_{OUT}$ )	$V_{DO}$	$I_{OUT} = 5\text{mA}$	300			mV
Load Regulation		$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ ; $V_{IN} = 3.0\text{V}$ $0\text{mA} < I_{OUT} < 5\text{mA}$			0.5	mV/mA
		$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ ; $V_{IN} = 3.0\text{V}$ $-2\text{mA} < I_{OUT} < 0\text{mA}$			0.5	mV/mA
Line Regulation		$2.8\text{V} < V_{IN} < 18\text{V}$ $I_{OUT} = 0\text{mA}$			90	ppm/V
Ripple Rejection	$\frac{\Delta V_{OUT}}{\Delta V_{IN}}$	$f = 60\text{Hz}$		60		dB
Quiescent Current	$I_Q$	$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ , No Load $V_{IN} = 18\text{V}$ $V_{IN} = 3.0\text{V}$		95 85	125	$\mu\text{A}$ $\mu\text{A}$
Short Circuit Current to Ground				25		mA
Noise Voltage		@ $25^\circ\text{C}$ 0.1Hz to 10Hz		20		$\mu\text{V}_{p-p}$
Turn-on Settling Time		To 0.1%, $C_L = 0.2 \mu\text{F}$		200		$\mu\text{s}$
Long-Term Stability		1,000 Hours @ $25^\circ\text{C}$		TBD		ppm/1000 hrs.
Output Voltage Hysteresis				TBD		ppm

# Preliminary Technical Data

# ADR121/ADR125/ADR127

ADR125 ELECTRICAL CHARACTERISTICS (@  $T_A = 25^\circ\text{C}$ ,  $V_{IN} = 5.3\text{V}$  to  $18\text{V}$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITION	Min	Typ	Max	UNITS
Output Voltage	$V_O$	@ $25^\circ\text{C}$				
B-Grade			4.994	5.0	5.006	V
A-Grade			4.988	5.0	5.012	V
Initial Accuracy Error	$V_{OERR}$	@ $25^\circ\text{C}$				
B-Grade			-0.12		+0.12	%
A-Grade			-0.24		+0.24	
Temperature Coefficient	$TCV_O$	$-40^\circ\text{C} < T_A < +125^\circ\text{C}$				
B-Grade				3	9	ppm/ $^\circ\text{C}$
A-Grade				15	25	ppm/ $^\circ\text{C}$
Dropout ( $V_{IN} - V_{OUT}$ )	$V_{DO}$	$I_{OUT} = 5\text{mA}$	300			mV
Load Regulation		$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ ; $V_{IN} = 5.5\text{V}$ $0\text{mA} < I_{OUT} < 5\text{mA}$			0.5	mV/mA
		$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ ; $V_{IN} = 5.5\text{V}$ $-2\text{mA} < I_{OUT} < 0\text{mA}$			0.5	mV/mA
Line Regulation		$5.3\text{V} < V_{IN} < 18\text{V}$ $I_{OUT} = 0\text{mA}$			30	ppm/V
Ripple Rejection	$\frac{\Delta V_{OUT}}{\Delta V_{IN}}$	$f = 60\text{Hz}$		60		dB
Quiescent Current	$I_Q$	$-40^\circ\text{C} < T_A < +125^\circ\text{C}$ , No Load $V_{IN} = 18\text{V}$ $V_{IN} = 5.3\text{V}$		95 85	125	$\mu\text{A}$ $\mu\text{A}$
Short Circuit Current to Ground				25		mA
Noise Voltage		@ $25^\circ\text{C}$ 0.1Hz to 10Hz		40		$\mu\text{V}_{p-p}$
Turn-on Settling Time		$T_O$ 0.1%, $C_L = 0.2 \mu\text{F}$		200		$\mu\text{s}$
Long-Term Stability		1,000 Hours @ $25^\circ\text{C}$		TBD		ppm/1000 hrs.
Output Voltage Hysteresis				TBD		ppm

## ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

$V_{IN}$ to GND.....	20V
Internal Power Dissipation <sup>2</sup>	
SOT-23 (RT) .....	400mW
Storage Temperature Range .....	$-65^\circ\text{C}$ to $+150^\circ\text{C}$
Specified Temperature Range.....	$-40^\circ\text{C}$ to $+120^\circ\text{C}$
Lead Temperature, Soldering	
Vapor Phase (60 sec).....	$+215^\circ\text{C}$
Infrared (15 secs).....	$+220^\circ\text{C}$

## TERMINOLOGY

### Temperature Coefficient

The change of output voltage with respect to operating temperature change normalized by the output voltage at 25°C. This parameter is expressed in ppm/°C and can be determined by

$$TCV_o [ppm/^\circ C] = \frac{V_o(T_2) - V_o(T_1)}{V_o(25^\circ C) \times (T_2 - T_1)} \times 10^6$$

where;

$V_o(25^\circ C) = V_o$  at 25°C.

$V_o(T_1) = V_o$  at Temperature 1.

$V_o(T_2) = V_o$  at Temperature 2.

### Line Regulation

The change in the output due to a specified change in input voltage. This parameter accounts for the effects of self-heating. Line regulation is expressed in either percent per volt, parts-per-million per volt, or microvolts per voltage changes in input voltage.

### Load Regulation

The change in output voltage due to a specified change in load current. This parameter accounts for the effects of self-heating. Load regulation is expressed in either microvolts per milliamper, parts-per-million per milliamper, or ohms of dc output resistance.

### Long-Term Stability

Typical shift of output voltage at 25°C on a sample of parts subjected to a test of 1,000 hours at 25°C.

$$\Delta V_o = V_o(t_o) - V_o(t_1)$$

$$\Delta V_o [ppm] = \frac{V_o(t_o) - V_o(t_1)}{V_o(t_o)} \times 10^6$$

where:

$V_o(t_0) = V_o$  at 25°C at Time 0.

$V_o(t_1) = V_o$  at 25°C after 1,000 hours operating at 25°C.

### Thermal Hysteresis

The change of output voltage after the device is cycled through temperature from +25°C to -40°C to +125°C and back to +25°C. This is a typical value from a sample of parts put through such a cycle.

$$V_{o\_HYS} = V_o(25^\circ C) - V_{o\_TC}$$

$$V_{o\_HYS} [ppm] = \frac{V_o(25^\circ C) - V_{o\_TC}}{V_o(25^\circ C)} \times 10^6$$

where:

$V_o(25^\circ C) = V_o$  at 25°C.

$V_{o\_TC} = V_o$  at 25°C after temperature cycle at +25°C to -40°C to +125°C and back to +25°C.

## NOTES

### Input Capacitor

Input capacitors are not required on the ADR12x. There is no limit for the value for the capacitor used on the input, but a 1µF to 10µF capacitor on the input improved transient response in the applications where there is a sudden supply change. An additional 0.1µF capacitor in parallel also helps reduce noise from the supply.

### Output Capacitor

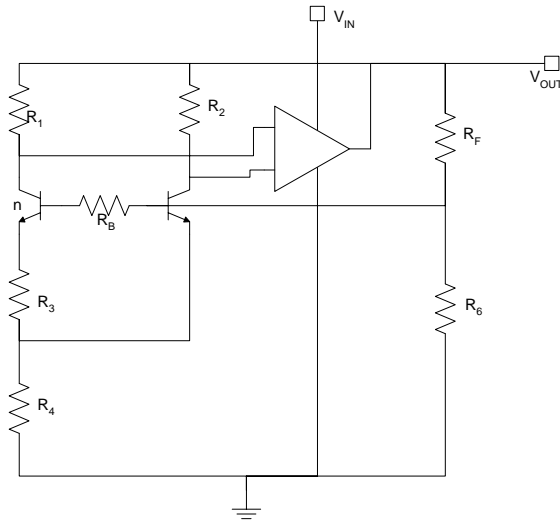
The ADR12x requires a small 0.1µF for stability. Additional 0.1µF to 10µF capacitance in parallel can improve load transient response. This acts as a source of stored energy for a sudden increase in load current. The only parameter affected with the additional capacitance is turn-on time.

## TYPICAL PERFORMANCE CHARACTERISTICS

# Preliminary Technical Data

## THEORY OF OPERATION

The ADR12x band gap references are the high performance solution for low supply voltage and low power applications. This family of precision references uses the underlying temperature characteristics of a silicon transistor's base emitter voltage in the forward-biased operating region. Under this condition, all such transistors have a  $-2\text{mV}/^\circ\text{C}$  temperature coefficient (TC) and a  $V_{BE}$  that, when extrapolated to absolute zero,  $0^\circ\text{K}$  (with collector current proportional to absolute temperature), approximates the silicon band gap voltage by summing a voltage that has equal and opposite temperature coefficient of  $2\text{mV}/^\circ\text{C}$  with the  $V_{BE}$  of a forward-biased transistor, an almost zero TC reference can be developed. In the ADR12x simplified circuit diagram shown in Figure xx, such a compensating voltage,  $V_{R4}$ , is derived by driving two transistors at different current densities and applying the resultant  $V_{R3}$  or  $V_{BE}$  ( $\Delta V_{BE}$ , which has a positive TC). The sum of  $V_{BE}$  and  $V_{R4}$  is then buffered and amplified to produce stable reference voltage outputs of 1.25V, 2.5V, and 5.0V.



## Devices Power Dissipation Considerations

The ADR12x family is capable of delivering load currents to 5mA with an input range from 3.0V to 18V. When this device is used in applications with large input voltages, care should be taken to avoid exceeding the specified maximum power dissipation or junction temperature because it could result in premature device failure. Use the following formula to calculate a device's maximum junction temperature or dissipation:

# ADR121/ADR125/ADR127

$$P_D = \frac{T_J - T_A}{\Theta_{JA}}$$

In this equation,  $T_J$  and  $T_A$  are respectively, the junction and the ambient temperatures,  $P_D$  is the device power dissipation, and  $\Theta_{JA}$  is the device package thermal resistance.

## APPLICATIONS

### Basic Voltage Reference Connection

The circuit in Figure a illustrates the basic configuration for the ADR12x family voltage reference.

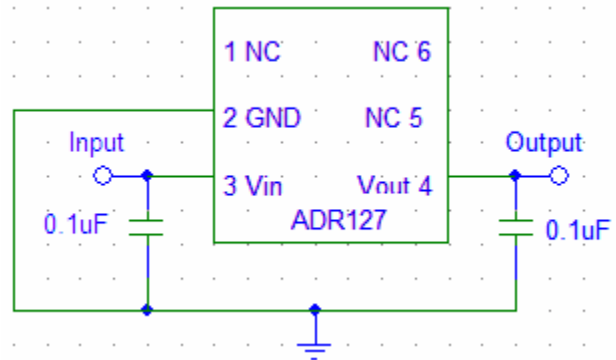


Figure xx. Basic Configuration for the ADR12x Family

### Stacking Reference ICs for Arbitrary Outputs

Some applications may require two reference voltage sources, which are a combined sum of the standard outputs. Figure xx shows how this stacked output reference can be implemented.

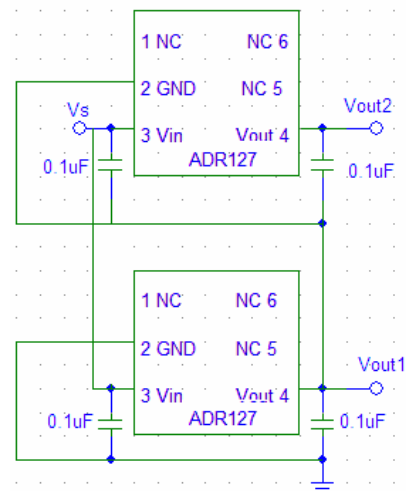


Figure xx. Stacking References with ADR12x

# Preliminary Technical Data

Two reference ICs are used, and fed from an unregulated input,  $V_{IN}$ . The outputs of the individual ICs are connected in series, which provides two output voltages,  $V_{OUT1}$  and  $V_{OUT2}$ .  $V_{OUT1}$  is the

terminal voltage of U1, while  $V_{OUT2}$  is the sum of this voltage and the terminal of U2. U1 and U2 are chosen for the two voltages that supply the required outputs (see Table xx). For example, if U1 and U2 are ADR127,  $V_{OUT1}$  is 1.25V and  $V_{OUT2}$  is 2.5V.

Table xx Output

U1/U2	$V_{OUT1}$	$V_{OUT2}$
ADR127/ADR121	1.25V	3.75V
ADR127/ADR125	1.25V	6.25V
ADR121/ADR125	2.5V	7.5V

## A Negative Precision Reference Without Precision Resistors

A negative reference is easily generated by adding an op amp, A1, and is configured in Figure xx.  $V_{OUT1}$  is at virtual ground and, therefore, the negative reference can be taken directly from the output of the op amp. The op amp must be dual-supply, low offset, and rail-to-rail if the negative supply voltage is close to the reference output.

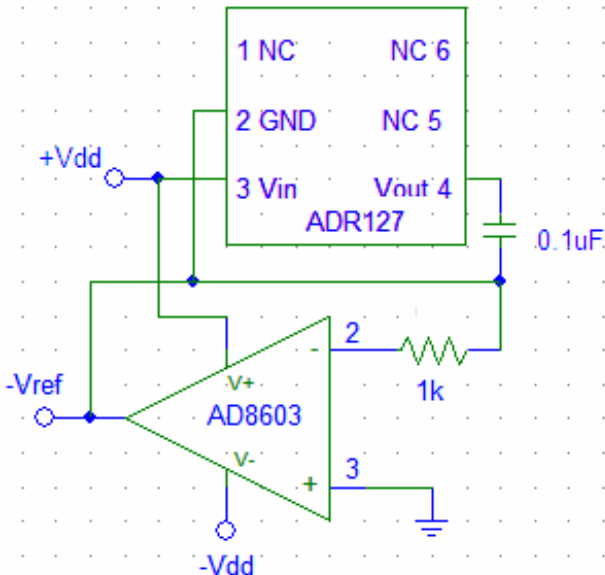


Figure xx. Negative Reference

## General Purpose Current Source

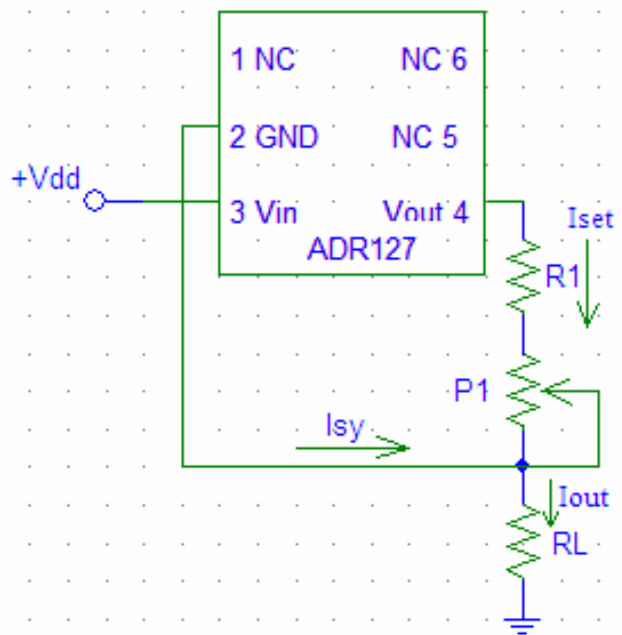
Many times in low power applications, the need arises for a precision current source that can

# ADR121/ADR125/ADR127

operate on low supply voltages. The ADR12x can be

configured as a precision current source (see Figure xx). The circuit configuration illustrated is a floating current source with a grounded load. The reference's output voltage is bootstrapped across  $R_{SET}$ , which sets the output current into the load. With this configuration, circuit precision is maintained

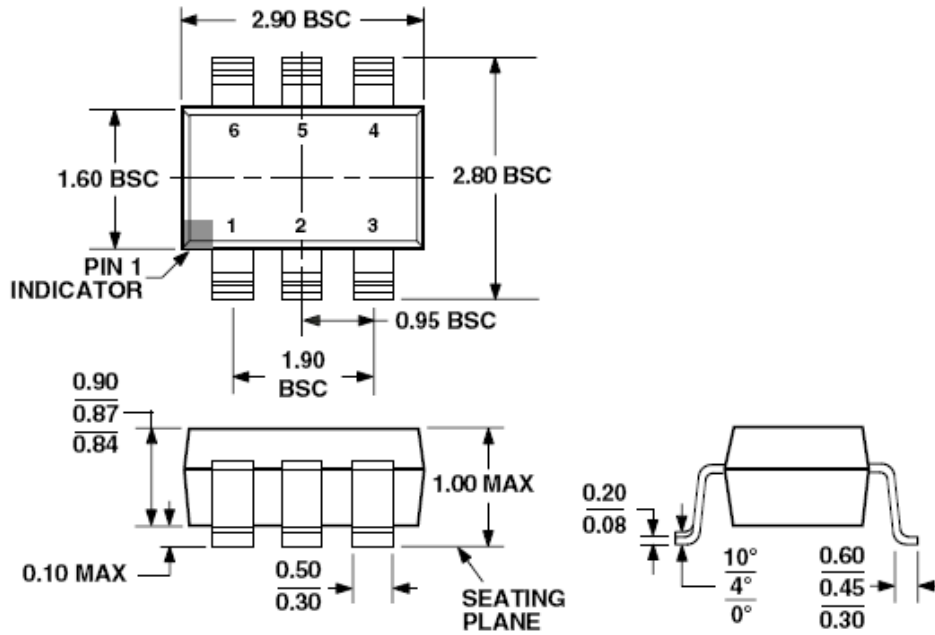
for load currents ranging from the reference's supply current, typically  $95\mu A$ , to approximately 5mA.



OUTLINE DIMENSIONS



6-Lead Thin Small Outline Transistor Package [TSOT]  
(UJ-6)  
Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-193AA

ORDERING GUIDE

Models*	Output Voltage (V <sub>O</sub> )	Initial Accuracy		Temperature Coefficient (ppm/°C)	Package Description	Package Option	Temperature Range (°C)	Branding
ADR127AUJZ-REEL7	1.25V	3mV	0.24%	25	TSOT	UJ-6	-40 to +125	R0S
ADR127BUJZ-REEL7	1.25V	1.5mV	0.12%	9	TSOT	UJ-6	-40 to +125	R0T
ADR121AUJZ-REEL7	2.5V	6mV	0.24%	25	TSOT	UJ-6	-40 to +125	R0N
ADR121BUJZ-REEL7	2.5V	3mV	0.12%	9	TSOT	UJ-6	-40 to +125	R0P
ADR125AUJZ-REEL7	5.0V	12mV	0.24%	25	TSOT	UJ-6	-40 to +125	R0Q
ADR125BUJZ-REEL7	5.0V	6mV	0.12%	9	TSOT	UJ-6	-40 to +125	R0R

\*3,000 pieces per reel